

Notice of References Cited

Application/Control No.

10/542,672

Applicant(s)/Patent Under
Reexamination
FRANZ ET AL.

Examiner

MEKONEN BEKELE

Art Unit

2624

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,359,572	04-2008	Liu et al.	382/274
*	B	US-6,040,858	03-2000	Ikeda, Eiichiro	348/242
*	C	US-6,163,621	12-2000	Paik et al.	382/169
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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